# MGSF1P02ELT1

**Preferred Device**

# Power MOSFET 750 mAmps, 20 Volts

## P–Channel SOT–23

These miniature surface mount MOSFETs low $R_{DS(on)}$ assure minimal power loss and conserve energy, making these devices ideal for use in space sensitive power management circuitry. Typical applications are dc–dc converters and power management in portable and battery–powered products such as computers, printers, PCMCIA cards, cellular and cordless telephones.

- Low $R_{DS(on)}$ Provides Higher Efficiency and Extends Battery Life
- Miniature SOT–23 Surface Mount Package Saves Board Space

**MAXIMUM RATINGS** ($T_J$ = 25°C unless otherwise noted)

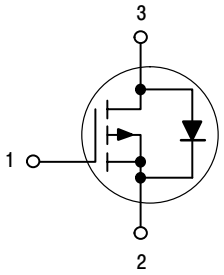
| Rating | Symbol | Value | Unit |
|---|---|---|---|
| Drain–to–Source Voltage | $V_{DSS}$ | 20 | Vdc |
| Gate–to–Source Voltage – Continuous | $V_{GS}$ | ± 8.0 | Vdc |
| Drain Current<br>– Continuous @ $T_A$ = 25°C<br>– Pulsed Drain Current ($t_p \le 10$ μs) | <br>$I_D$<br>$I_{DM}$ | <br>750<br>2000 | mA |
| Total Power Dissipation @ $T_A$ = 25°C | $P_D$ | 400 | mW |
| Operating and Storage Temperature Range | $T_J$, $T_{stg}$ | – 55 to 150 | °C |
| Thermal Resistance – Junction–to–Ambient | $R_{\theta JA}$ | 300 | °C/W |
| Maximum Lead Temperature for Soldering Purposes, 1/8″ from case for 10 seconds | $T_L$ | 260 | °C |

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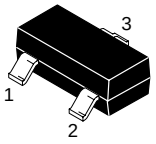
http://onsemi.com

**750 mAMPS**
**20 VOLTS**
**$R_{DS(on)}$ = 260 mΩ**

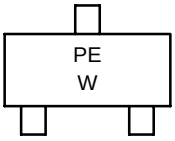
**P–Channel**




**MARKING DIAGRAM**

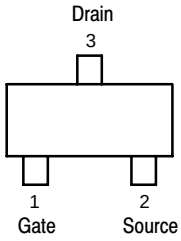



**SOT–23**
**CASE 318**
**STYLE 21**




W = Work Week

**PIN ASSIGNMENT**




**ORDERING INFORMATION**

| Device | Package | Shipping |
|---|---|---|
| MGSF1P02ELT1 | SOT–23 | 3000 Tape & Reel |
| MGSF1P02ELT3 | SOT–23 | 10,000 Tape & Reel |

**Preferred** devices are recommended choices for future use and best overall value.

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**ELECTRICAL CHARACTERISTICS** ($T_A$ = 25°C unless otherwise noted)

| Characteristic | | Symbol | Min | Typ | Max | Unit |
|---|---|---|---|---|---|---|
| **OFF CHARACTERISTICS** | | | | | | |
| Drain–to–Source Breakdown Voltage ($V_{GS}$ = 0 Vdc, $I_D$ = 10 μAdc) | | $V_{(BR)DSS}$ | 20 | – | – | Vdc |
| Zero Gate Voltage Drain Current ($V_{DS}$ = 16 Vdc, $V_{GS}$ = 0 Vdc)<br>($V_{DS}$ = 16 Vdc, $V_{GS}$ = 0 Vdc, $T_J$ = 125°C) | | $I_{DSS}$ | –<br>– | –<br>– | 1.0<br>10 | μAdc |
| Gate–Body Leakage Current ($V_{GS}$ = ± 8.0 Vdc, $V_{DS}$ = 0 Vdc) | | $I_{GSS}$ | – | – | ±100 | nAdc |
| **ON CHARACTERISTICS** (Note 1.) | | | | | | |
| Gate Threshold Voltage ($V_{DS}$ = $V_{GS}$, $I_D$ = 250 μAdc) | | $V_{GS(th)}$ | 0.7 | 1.0 | 1.25 | Vdc |
| Static Drain–to–Source On–Resistance ($V_{GS}$ = 4.5 Vdc, $I_D$ = 0.75 Adc)<br>($V_{GS}$ = 2.5 Vdc, $I_D$ = 0.5 Adc) | | $r_{DS(on)}$ | –<br>– | 0.22<br>0.40 | 0.26<br>0.50 | Ohms |
| **DYNAMIC CHARACTERISTICS** | | | | | | |
| Input Capacitance | ($V_{DS}$ = 5.0 Vdc) | $C_{iss}$ | – | 140 | – | pF |
| Output Capacitance | ($V_{DS}$ = 5.0 Vdc) | $C_{oss}$ | – | 130 | – | |
| Transfer Capacitance | ($V_{DG}$ = 5.0 Vdc) | $C_{rss}$ | – | 50 | – | |
| **SWITCHING CHARACTERISTICS** (Note 2.) | | | | | | |
| Turn–On Delay Time | ($V_{DD}$ = 5 Vdc, $I_D$ = 1.0 Adc, $R_L$ = 5 Ω, $R_G$ = 6 Ω) | $t_{d(on)}$ | – | 9.5 | – | ns |
| Rise Time | | $t_r$ | – | 32 | – | |
| Turn–Off Delay Time | | $t_{d(off)}$ | – | 200 | – | |
| Fall Time | | $t_f$ | – | 200 | – | |
| Total Gate Charge | ($V_{DS}$ = 16 Vdc, $I_D$ = 1.5 Adc, $V_{GS}$ = 4.0 Vdc) | $Q_T$ | – | 5500 | – | pC |
| **SOURCE–DRAIN DIODE CHARACTERISTICS** | | | | | | |
| Continuous Current | | $I_S$ | – | – | 0.6 | A |
| Pulsed Current | | $I_{SM}$ | – | – | 0.75 | |
| Forward Voltage (Note 2.) ($V_{GS}$ = 0 Vdc, $I_S$ = 0.6 Adc) | | $V_{SD}$ | – | – | 1.0 | V |

1. Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
2. Switching characteristics are independent of operating junction temperature.

## TYPICAL ELECTRICAL CHARACTERISTICS

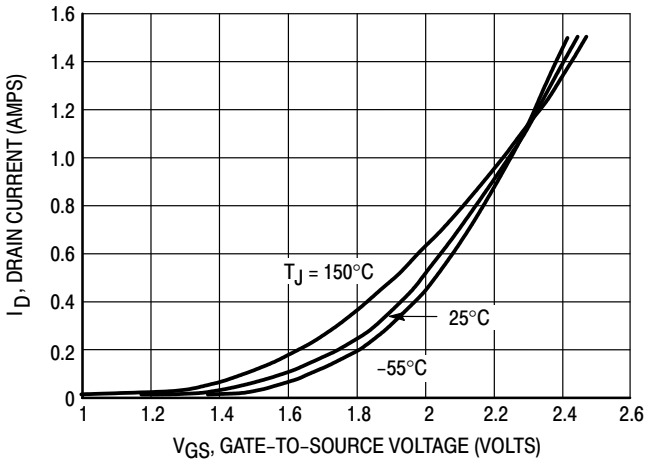



**Figure 1. Transfer Characteristics**

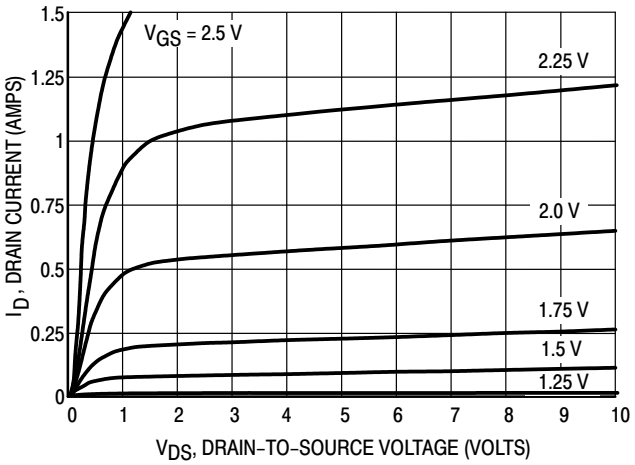



**Figure 2. On–Region Characteristics**

## TYPICAL ELECTRICAL CHARACTERISTICS

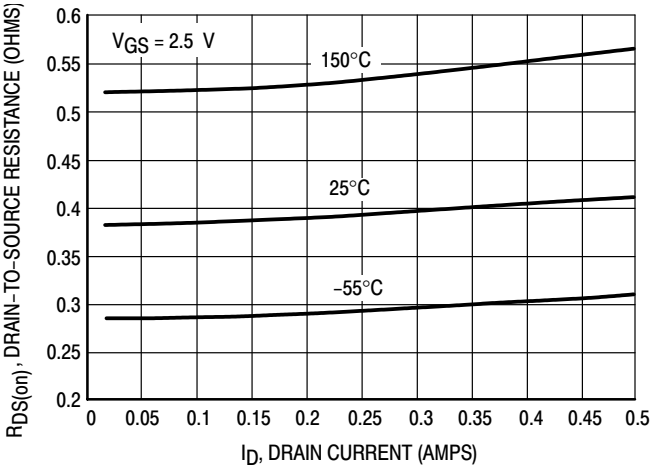



**Figure 3. On−Resistance versus Drain Current**

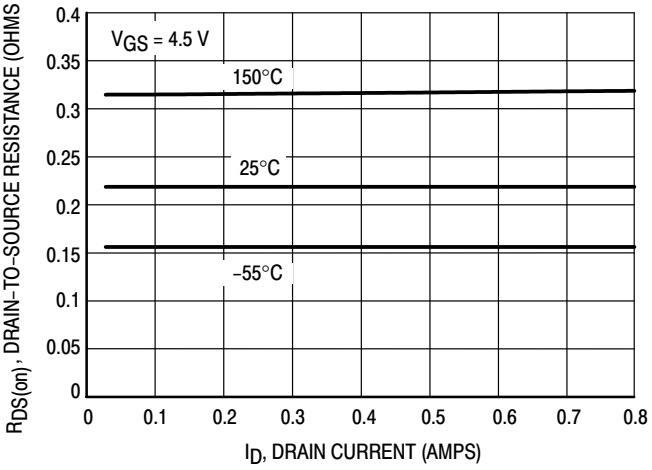



**Figure 4. On−Resistance versus Drain Current**

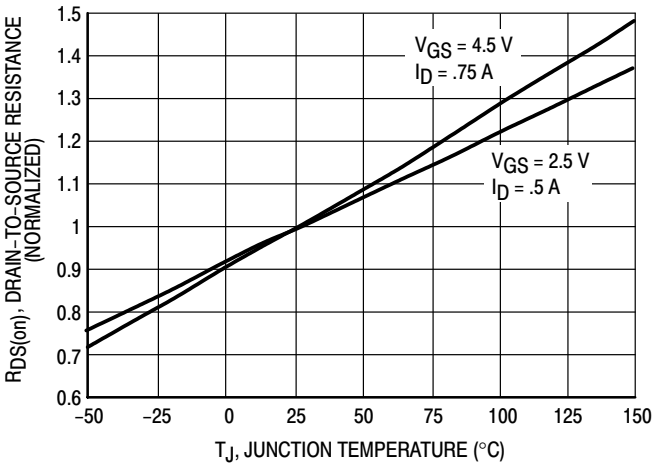



**Figure 5. On−Resistance Variation with Temperature**

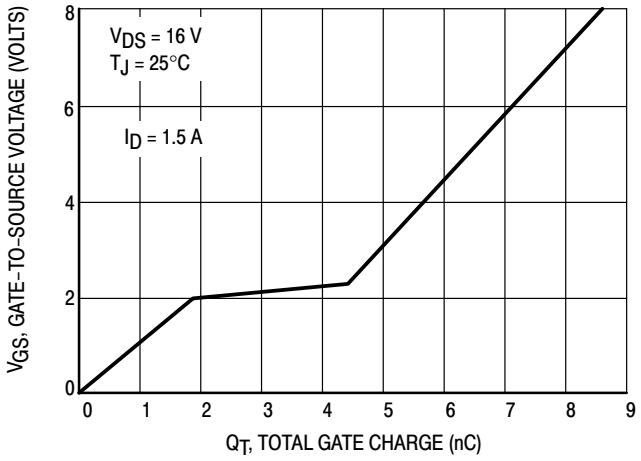



**Figure 6. Gate Charge**

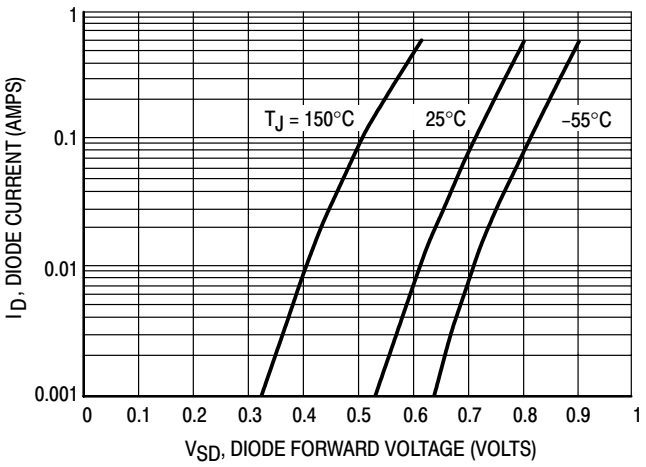



**Figure 7. Body Diode Forward Voltage**

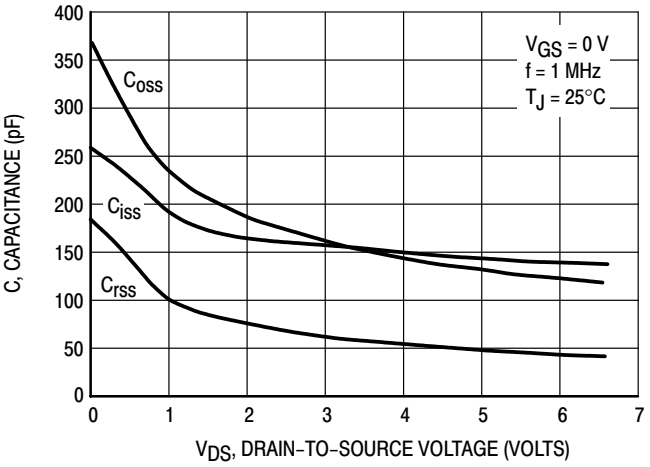
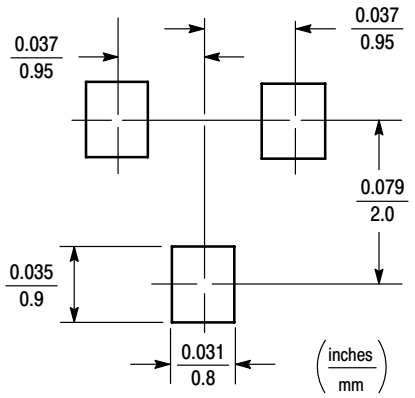



**Figure 8. Capacitance Variation**

# INFORMATION FOR USING THE SOT–23 SURFACE MOUNT PACKAGE

## MINIMUM RECOMMENDED FOOTPRINT FOR SURFACE MOUNTED APPLICATIONS

Surface mount board layout is a critical portion of the total design. The footprint for the semiconductor packages must be the correct size to insure proper solder connection interface between the board and the package. With the correct pad geometry, the packages will self align when subjected to a solder reflow process.




## SOT–23 POWER DISSIPATION

The power dissipation of the SOT–23 is a function of the drain pad size. This can vary from the minimum pad size for soldering to a pad size given for maximum power dissipation. Power dissipation for a surface mount device is determined by $T_{J(max)}$, the maximum rated junction temperature of the die, $R_{\theta JA}$, the thermal resistance from the device junction to ambient, and the operating temperature, $T_A$. Using the values provided on the data sheet for the SOT–23 package, $P_D$ can be calculated as follows:

$$P_D = \frac{T_{J(max)} - T_A}{R_{\theta JA}}$$

The values for the equation are found in the maximum ratings table on the data sheet. Substituting these values into the equation for an ambient temperature $T_A$ of 25°C, one can calculate the power dissipation of the device which in this case is 416 milliwatts.

$$P_D = \frac{150°C - 25°C}{300°C/W} = 416 \text{ milliwatts}$$

The 300°C/W for the SOT–23 package assumes the use of the recommended footprint on a glass epoxy printed circuit board to achieve a power dissipation of 416 milliwatts. There are other alternatives to achieving higher power dissipation from the SOT–23 package. Another alternative would be to use a ceramic substrate or an aluminum core board such as Thermal Clad™. Using a board material such as Thermal Clad, an aluminum core board, the power dissipation can be doubled using the same footprint.

## SOLDERING PRECAUTIONS

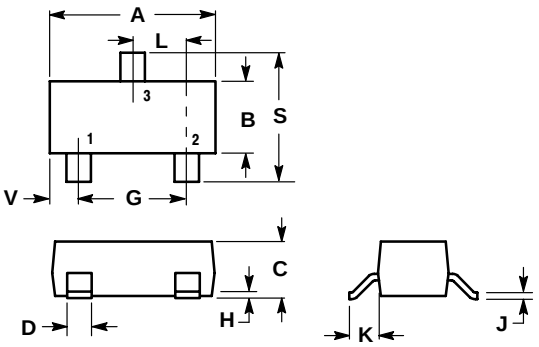
The melting temperature of solder is higher than the rated temperature of the device. When the entire device is heated to a high temperature, failure to complete soldering within a short time could result in device failure. Therefore, the following items should always be observed in order to minimize the thermal stress to which the devices are subjected.

- Always preheat the device.
- The delta temperature between the preheat and soldering should be 100°C or less.*
- When preheating and soldering, the temperature of the leads and the case must not exceed the maximum temperature ratings as shown on the data sheet. When using infrared heating with the reflow soldering method, the difference shall be a maximum of 10°C.
- The soldering temperature and time shall not exceed 260°C for more than 10 seconds.
- When shifting from preheating to soldering, the maximum temperature gradient shall be 5°C or less.
- After soldering has been completed, the device should be allowed to cool naturally for at least three minutes. Gradual cooling should be used as the use of forced cooling will increase the temperature gradient and result in latent failure due to mechanical stress.
- Mechanical stress or shock should not be applied during cooling.

* Soldering a device without preheating can cause excessive thermal shock and stress which can result in damage to the device.

## PACKAGE DIMENSIONS

**SOT–23 (TO–236)**
CASE 318–08
ISSUE AF




NOTES:
1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
2. CONTROLLING DIMENSION: INCH.
3. MAXIMUM LEAD THICKNESS INCLUDES LEAD FINISH THICKNESS. MINIMUM LEAD THICKNESS IS THE MINIMUM THICKNESS OF BASE MATERIAL.

| | INCHES | | MILLIMETERS | |
|---|---|---|---|---|
| DIM | MIN | MAX | MIN | MAX |
| A | 0.1102 | 0.1197 | 2.80 | 3.04 |
| B | 0.0472 | 0.0551 | 1.20 | 1.40 |
| C | 0.0350 | 0.0440 | 0.89 | 1.11 |
| D | 0.0150 | 0.0200 | 0.37 | 0.50 |
| G | 0.0701 | 0.0807 | 1.78 | 2.04 |
| H | 0.0005 | 0.0040 | 0.013 | 0.100 |
| J | 0.0034 | 0.0070 | 0.085 | 0.177 |
| K | 0.0140 | 0.0285 | 0.35 | 0.69 |
| L | 0.0350 | 0.0401 | 0.89 | 1.02 |
| S | 0.0830 | 0.1039 | 2.10 | 2.64 |
| V | 0.0177 | 0.0236 | 0.45 | 0.60 |

STYLE 21:
PIN 1. GATE
2. SOURCE
3. DRAIN

# Notes

# Notes

Thermal Clad is a registered trademark of the Bergquist Company.

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